

Notice of References Cited	Application/Control No. 10/090,218	Applicant(s)/Patent Under Reexamination PETRUZIELLO, MICHAEL J.	
	Examiner Ellen Kim	Art Unit 2874	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,295,401	09-2001	Rutterman et al.	385/114
	B	US-4,142,776	03-1979	Cherin et al.	385/71
	C	US-5,400,426	03-1995	de Jong et al.	385/95
	D	US-6,160,940	12-2000	Summers et al.	385/110
	E	US-4,456,331	06-1984	Whitehead et al.	385/105
	F	US-6,141,472	10-2000	Ishikawa et al.	385/105
	G	US-5,071,221	12-1991	Fujitani et al.	385/100
	H	US-4,435,238	03-1984	Smith, John C.	156/171
	I	US-4,978,377	12-1990	Brehm et al.	65/403
	J	US-4,869,573	09-1989	Radage et al.	385/108
	K	US-5,353,365	10-1994	Dumas et al.	385/102
	L	US-5,825,961	10-1998	Wilkins et al.	385/135
	M	US-6,499,886	12-2002	Mizuno et al.	385/70

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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